Blue Clover Devices

Test Plan Reference

PLT

0.6.5

2019-11-06

Revision History

Revision History

Revision 0.6.5 2019-10-07

- Add STM32F2 and ST32F2_STLink targets

Revision 0.6.4 2019-10-08

No change

Revision 0.6.3 2019-10-07

- document `noflush` option for uart and uartExpect commands
- eval command
- uart: extract multiple keys
- ble test: Low-level BLE testing

Revision 0.6.2 2019-10-03

- document JLink/ST-Link target variants
- update initial example
- scan: ANY format
- serial request: user key extraction

Revision 0.5.7 2019-08-22

- `label` command: Document ZPL templates
- add Nordic nRF91 Cortex-M33 targets

Revision 0.5.6 2019-08-19

- Document retry mechanism for test items and test item steps
- Document GATT-level BLE commands
- Document `image` command test step to set background images
- Document setting Label substitutions with the `label` command test step
- add AVRATmega168P/PB targets

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- `measure`: Document `reference` argument
- Document `nfc` command

Revision 0.5.1	2019-04-16
• Add `CC1352` target • Document `define` command	
Revision 0.5.0	2019-03-31
• Document `freq` command • Document `measure` command • Document `mux` command • Document `pin` command • Document `power` command • Document `short` command • Document `uartCfg` command	
Revision 0.4.9	2019-03-28
• Document `serial request` command • Update UART port names	
Revision 0.4.8	2019-03-08
Renamed to Test Plan Reference	
Revision 0.4.7	2019-03-08
Split off from System Manual	

Table of Contents

Preface

Document describing the test suite definition for use with the Production Line Tool.

1. Test Suite Reference

1.1 Test Suites

Example: A minimal test suite, with a single test item, scanning a bar code.

```
title: "PLT demo: Scan"
suite:
  - ident: SCAN-T1
    title: Scan MAC address
    steps:
      - command: scan ANY
```

1.1.1 Test Suite Structure

PLT test suites are encoded as YAML text files, starting with the test suite title.

```
title: "PLT demo: Scan"
```

The `title:` is followed by the `suite:` section, containing the test items in the test plan.

1.1.1.1 Test Items

Test items are identified with an `ident:` line, can contain a descriptive `title`, and should contain one or more test item steps.

During test execution, all test item steps need to complete successfully for the test item to succeed.

1.1.1.2 Test Item Steps

Test item steps consist of `command:` or `uartcmd:` blocks. A Test Item can contain multiple Test Item steps.

1.1.1.3 Retries

Retry counts can be set for at the test item of test item step level, by adding a `retry:` field.

```
title: "Retries"
suite:
  - ident: T1
    title: Test Item retries
    retry: 3
    steps:
      - command: sleepms 1000
      - command: operator Manual
  - ident: T2
    title: Test Item retries
    steps:
      - command: sleepms 1000
      - command: operator Manual
        retry: 3
```

1.1.2 Basic Example

A basic In-Circuit Test suite for the PLT demo board.

```
title: "v0.1.8 (Green)"
suite:
  - ident: ICT-T1
    title: Identify DUT
    steps:
      - command: identify nRF52
  - ident: ICT-T2
    title: Erase nRF52
    steps:
      - command: erase nRF52
  - ident: ICT-T3
    title: Program DEMO-BOARD FW nRF52
    steps:
      - command: program nRF52 s132_nrf52_6.0.0_softdevice.hex,ly10-demo-fw-
0.1.8.hex,none
  - ident: ICT-T4
    title: BLE discovery
    steps:
      - command: bledis %BLEMAC% 30  # Wait up to 30 seconds for BLE discovery to
complete
```

1.2 Test Commands

1.2.1 ble gatt - GATT-level BLE Tests

Perform GATT-level BLE interactions with the DUT.

Usage:

```
ble gatt connect addr:<address> [<timeout> [<minRSSI>]]
ble gatt connect name:<name> [<timeout> [<minRSSI>]]
ble gatt disconnect
ble gatt discover
ble gatt match char:<charUUID> <matchHex>
ble gatt read char:<charUUID> <matchHex>
ble gatt sub char:<charUUID>
ble gatt write char:<charUUID> <valueHex>
```

Argument	Description
name	GAP name advertised by DUT.
address	BLE MAC address used by the DUT.
timeout	Timeout, in seconds
minRSSI	RSSI treshold (optional)
`connect`	Connect to GATT peripheral
`disconnect`	Disconnect from GATT peripheral
`discover`	Discover GATT services and characteristics
`match`	Match a value for a subscribed characteristic
`read`	Read a GATT characteristic
`sub`	Subscribe to notifications from a GATT characteristic
`write`	Write to a GATT characteristic

Example: Validate BLE Device Information Service

```
title: "DIS Validation"
suite:
  - ident: ICT-T1
    title: Identify DUT
    steps:
    - command: identify nRF52
  - ident: ICT-T2
    title: Program LY10-DEMO-BOARD FW
    steps:
    - command: program nRF52 s132_nrf52_6.0.0_softdevice.hex,ly10-demo-fw-
0.1.7.hex,none
  - ident: ICT-T3
    title: Validate BLE DIS
    steps:
    - command: ble gatt connect addr:%ble_mac% 10
    - command: ble gatt discover
    # GAP:Device Name
    - command: ble gatt read char:2a00 4c5931302d44454d4f5f424f415244 # "LY10-
DEMO_BOARD"
    # GAP Appearance
    - command: ble gatt read char:2a01 0000
    # GAP:Peripheral Preferred Connection Parameters
    - command: ble gatt read char:2a04 0600080200009001
    # GAP:Central Address Resolution
    - command: ble gatt read char:2aa6 01
    # DIS:Manufacturer Name String
    - command: ble gatt read char:2a29 424344 # "BCD"
    # DIS:Model Number String
    - command: ble gatt read char:2a24 4c5931302d44454d4f5f424f415244 # "LY10-
DEMO_BOARD"
    # DIS:Hardware Revision String
    - command: ble gatt read char:2a27 32303139 # "2019"
    # DIS:Firmware Revision String
    - command: ble gatt read char:2a26 302e312e37 # "0.1.7"
    # DIS:Software Revision String
    - command: ble gatt read char:2a28 312e322e33 # "1.2.3"
    - command: ble gatt disconnect
```

1.2.2 ble test - Low-level BLE Tests

Perform Low-level BLE tests.

Usage:

```
ble test recv <channel>
ble test xmit <channel> [<length> [<payload>]]
ble test stop
```

Argument	Description
channel	BLE channel
length	Test packet payload length
payload	Test packet payload type

1.2.3 bledis - Test BLE Discovery

Establishes a BLE connection to the DUT and discovers GATT services.

Usage:

```
bledis %BLEMAC%|<name> [<timeout> [<minRSSI>]]
```

Argument	Description
name	GAP name advertised by DUT. `%BLEMAC%` to specify the DUT's BLE MAC address instead
timeout	Timeout, in seconds

Argument	Description
minRSSI	RSSI treshold (optional)

Example: BLE discovery of identified BLE HW MAC address.

```
- ident: ICT-T1
  title: Identify DUT
  steps:
    - command: identify nRF52
- ident: ICT-T2
  title: BLE Discovery
  steps:
    - command: bledis %BLEMAC% 30 -60
```

1.2.4 define - Define user key

Manually defines a test plan key, which will be emedded in the test report and serial number requests performed as part of the current test plan.

Usage:

```
define <key> <value>
```

Argument	Description
key	Name of the test plan key.
value	Value for the key; can be any kind of string value.

```
- ident: ICT-T0
  title: Set variables
  steps:
    - command: define work_order 1011X02
- ident: ICT-T1
  title: Request serial
  steps:
    - command: request serial
```

1.2.5 erase - Erase DUT Flash

Erase DUT MCU on-board flash.

Usage:

```
erase <target> [UART0|UART1]
```

Argument	Description
target	Target to erase
`UART0`, `UART1`	Port for UART targets

Supported ***target*** values:

target	Description
`AVRATmega168P_ISP`	Atmel AVR ATmega168P(A) (JTAG:ISP)
`AVRATmega168P_XPm`	Atmel AVR ATmega168P(A) (USB, XPmini)
`AVRATmega168PB_ISP`	Atmel AVR ATmega168PB (JTAG:ISP)
`AVRATmega168PB_XPm`	Atmel AVR ATmega168PB (USB, XPmini)
`CC1352`	TI CC1352 RFSoC
`DA14580`	Dialog DA14580 RFSoC
`ESP32`	Espressif ESP32 RFSoC (JTAG)

target	Description
`ESP32_HomeKit`	Espressif ESP32 RFSoC (JTAG; HomeKit)
`ESP32_JTAG`	Espressif ESP32 RFSoC (JTAG)
`ESP32_UART`	Espressif ESP32 RFSoC (esptool)
`nRF52`	Nordic nRF52 RFSoC (SWD)
`nRF52_JLink`	Nordic nRF52 RFSoC (USB, JLink)
`nRF91`	Nordic nRF9160 RFSoC:Cortex-M33 (SWD)
`nRF91_JLink`	Nordic nRF9160 RFSoC:Cortex-M33 (USB, JLink)
`STM32F2`	ST STM32F2xx MCU (SWD)
`STM32F2_STLink`	ST STM32F2xx MCU (USB, ST-Link)
`STM32F4`	ST STM32F4xx MCU (SWD)
`STM32F4_STLink`	ST STM32F4xx MCU (USB, ST-Link)
`STM32L4`	ST STM32L4xx MCU (SWD)
`STM32L4_STLink`	ST STM32L4xx MCU (USB, ST-Link)

Example: Erase STM32L4 on-board flash.

```
- ident: ICT-T1
  title: Erase
  steps:
  - command: erase STM32L4
```

1.2.6 eval - Evaluate Expression

Evaluate an expression.

```
eval <expression>
```

Argument	Description
expression	Expression to evaluate

Operator	Description
+	Addition, concatenation
-	Subtraction, Negation
/	Division
*	Multiplication
**	Power
%	Modulo
&	Bitwise And
|	Bitwise Or
^	Bitwise Xor
~	Bitwise Not
>>	Right shift
<<	Left shift
!	Inversion
&&	Logican And
||	Logican Or
?	Ternary True
:	Ternary False
??	Null coalescence

Operator	Description
>	Greater than
<=	Less than or equal
>=	Greater than or equal
=~	Regex match
!~	Regex mismatch

Example:

```
title: "Eval"
suite:
- ident: E0
  title: Eval
  steps:
  - command: define test "AC1D"
  - command: eval "test != 'FOOBAR'" # PASS
  - command: eval "test == 'AC1D'" # PASS
  - command: eval "test != 'AC1D'" # FAIL
```

1.2.7 extflash_write - Write Peripheral Flash

Write DUT periperal flash.

Usage:

```
extflash_write UART0|UART1 <filename>
```

Argument	Description
`UART0`, `UART1`	Port for UART targets
filename	Firmware Element Filename

1.2.8 freq - Frequency Monitor Control

Set the channel to use for frequency measurements.

Usage:

```
freq 0|1
```

Argument	Description
`0`	Use CLK0
`1`	Use CLK1

Example: Measure CLK1 frequency

```
suite:
  - ident: ICT-T1
    title: Measure CLK1 frequency
    steps:
    - command: freq 1
    - command: sleepms 1000
    - command: measure frequency 7.90-8.10MHz
```

1.2.9 identify - Identify DUT

Identify DUT MCU and/or RF peripherals.

Usage:

```
identify <target> [UART0|UART1]
```

Argument	Description
target	Target to identify
`UART0`, `UART1`	Port for UART targets

Supported ***target*** values:

target	Description
`AVRATmega168P_ISP`	Atmel AVR ATmega168P(A) (JTAG:ISP)
`AVRATmega168P_XPm`	Atmel AVR ATmega168P(A) (USB, XPmini)
`AVRATmega168PB_ISP`	Atmel AVR ATmega168PB (JTAG:ISP)
`AVRATmega168PB_XPm`	Atmel AVR ATmega168PB (USB, XPmini)
`CC1352`	TI CC1352 RFSoC
`DA14580`	Dialog DA14580 RFSoC
`ESP32`	Espressif ESP32 RFSoC (JTAG)
`ESP32_HomeKit`	Espressif ESP32 RFSoC (JTAG; HomeKit)
`ESP32_JTAG`	Espressif ESP32 RFSoC (JTAG)
`ESP32_UART`	Espressif ESP32 RFSoC (esptool)
`nRF52`	Nordic nRF52 RFSoC (SWD)
`nRF52_JLink`	Nordic nRF52 RFSoC (USB, JLink)
`nRF91`	Nordic nRF9160 RFSoC:Cortex-M33 (SWD)
`nRF91_JLink`	Nordic nRF9160 RFSoC:Cortex-M33 (USB, JLink)
`STM32F2`	ST STM32F2xx MCU (SWD)
`STM32F2_STLink`	ST STM32F2xx MCU (USB, ST-Link)
`STM32F4`	ST STM32F4xx MCU (SWD)
`STM32F4_STLink`	ST STM32F4xx MCU (USB, ST-Link)
`STM32L4`	ST STM32L4xx MCU (SWD)
`STM32L4_STLink`	ST STM32L4xx MCU (USB, ST-Link)

1.2.10 image - Set background image

Usage:

```
image set <filename>
image clear
```

Argument	Description
`set`	Set background image
`clear`	Clear background image
filename	Filename of the PNG or JPEG element to show

Example: Background for operator test

```
title: "OLED Image"
suite:
- ident: ICT-T1
  title: Show image
  steps:
  - command: image set fighter.png
  - command: operator "Manual test"
```

1.2.11 label - Set Label Substitutions

Usage:

```
label keys <key> [<key>...]
```

The label command defines additional keys to substitute in the ZPL sent to the barcode printer, in addition to the default substitution keys.

Key	Description
`DUT_PRODUCT`	Product name
`DUT_VERSION`	Version
`DUT_SERIAL`	DUT Serial number
`MAC_ADDRESS`	MAC address
`BLEMAC`	BLE MAC address
`FAILURE_MSG`	Test failure

Example: Substitute CODE

```
title: "Custom bacode substitution"
suite:
- ident: ICT-T0
  title: Define label keys
  steps:
  - command: define CODE 12345
  - command: label keys CODE
```

The default ZPL generated by the PLT upon completion of a YAML test plan specification can be overridden by uploading `template-pass.zpl` and `template-fail.zpl` elements as part of the Release deployed through PLTcloud.

```
^FX template-fail.zpl - ZPL Template for failing DUTs
^XA^LH40,30
^MD2
^FO0,10^ADN,30,8^FDCODE^FS
^FO0,80^ADN,30,8^FDN/G^FS
^XZ
```

```
^FX template-pass.zpl - ZPL Template for DUTs that pass testing
^XA
~SD22
^CF0,30
^FO40,20^FDProduct:DUT_PRODUCT^FS
^FO40,30^FDVersion:DUT_VERSION^FS
^FO40,40^FDS/N:DUT_SERIAL^FS
^FO40,50^FDMAC Address:MAC_ADDRESS^FS
^FO40,60^FDBLE Address:BLEMAC^FS
^FO40,70^FDFailure:FAILURE_MSG^FS
^FO40,80^FDCode:CODE^FS
^FO40,170^BY2
^BCN,50,N,N,N
^FDMAC_ADDRESS^FS
^XZ
```

1.2.12 measure - Probe Measurement

Usage:

```
measure <channel> [<signal>] <range> [<reference>]
```

Argument	Description
channel	Measurement channel
signal	DDTPxx or RDTPxx probe for `pin` measurement
range	Acceptable range
reference	Reference value

The `measure` command supports the following channels:

channel	**Description**
`current3V3`	3V3 current draw
`current5V`	5V current draw
`currentVARV`	VARV current draw
`frequency`	Frequency (CLK0 or CLK1)
`impedance`	Impedance measurement (RVREF/RA)
`pin`	Digital pin measurement (DDTPxx/RDTPxx)
`voltageDATP07`	DATP07 voltage
`voltageDATP08`	DATP08 voltage
`voltageDATP09`	DATP09 voltage
`voltageDATP10`	DATP10 voltage
`voltageDATP11`	DATP11 voltage
`voltageDATP12`	DATP12 voltage
`voltageMUX0`	MUX0 voltage
`voltageMUX1`	MUX1 voltage
`voltageMUX2`	MUX2 voltage
`voltageMUX3`	MUX3 voltage

Example: Electrical measurements

```
suite:
- ident: ICT-T1
  title: Measure CLK0 frequency
  steps:
  - command: freq 0
  - command: sleepms 1000
  - command: measure frequency 32.75-32.78kHz
- ident: ICT-T2
  title: Measure Impedance
  steps:
  - command: mux 0 RATP02
  - command: mux 1 RATP03
  - command: mux 2 RA
  - command: mux 3 RVREF
  - command: short 0 2 set
  - command: short 1 3 set
  - command: measure impedance 750-1000mOhm 3.3V
  - command: short 0 2 release
  - command: short 1 3 release
  - command: sleepms 1500
  - command: measure impedance 2-10Ohm 3300
- ident: ICT-T3
  title: Measure Currents
  steps:
  - command: measure current3V3 <1A
  - command: measure current5V 0.1-0.5A
  - command: measure currentVARV >100mA
- ident: ICT-T4
  title: Measure Voltages
  steps:
  - command: mux 0 DATP00
  - command: mux 1 DATP01
  - command: mux 2 RATP00
  - command: mux 3 RATP17
  - command: measure voltageMUX0 >1V
  - command: measure voltageMUX1 <3300mV
  - command: measure voltageMUX2 >100mV
  - command: measure voltageMUX3 1500-1800mV
  - command: measure voltageDATP07 200-6000mV
  - command: measure voltageDATP08 -0.2-0.1V
  - command: measure voltageDATP09 0-4V
  - command: measure voltageDATP10 -0.1-3.3V
  - command: measure voltageDATP11 0-3.4V
  - command: measure voltageDATP12 -0.1-3.4V
```

Example: Digital pin measurement

```
suite:
- ident: ICT-T1
  title: Set Digital pins
  steps:
  - command: pin RDTP21 input pullup
  - command: pin DDTP04 input
- ident: ICT-T2
  title: Read Digital pins
  steps:
  - command: measure pin RDTP21 low
  - command: measure pin DDTP04 high
```

1.2.13 mux - Multiplex Control

Select a probe or signal for a multiplex channel.

Usage:

```
mux <channel> <signal>
```

Argument	Description

Argument	Description
channel	Multiplex channel (0..3)
signal	Probe or signal

The following signals and probes can be assigned to a multiplex channel:

signal	MUX	Description
`DATP00`..`DATP06`	0, 1	Direct Analog Test Probes
`RATP00`..`RATP31`	0, 1	Routed Analog Test Probes
`DDTP00`..`DDTP08`	2, 3	Direct Digital Test Probes
`RVREF`	all	Impedance measurement, reference voltage
`RA`	all	Impedance measurement, test voltage
`GND`	all	Ground
`3V3OUT`	all	3.3V power rail
`5VOUT`	all	5.0V power rail
`VARVDIV`	all	VARV power rail, after 1/3 voltage divider

Example: Multiplex control

```
suite:
- ident: ICT-T1
  title: Setup MUX
  steps:
  - command: mux 0 DATP02
  - command: mux 1 DATP03
  - command: mux 2 RA
  - command: mux 3 RVREF
  - command: short 0 2 set
  - command: short 1 3 set
- ident: ICT-T2
  title: Measure impedance DATP02..DATP03
  steps:
  - command: measure impedance 10-200kOhm
```

1.2.14 nfc - NFC Handling

Manipulate NFC cards.

Usage:

```
nfc write <TAGTYPE> <payload>...
```

Argument	Description
tagtype	Tag type (`NTAG203`, `NTAG213` or `NTAG216`)
payload	NDEF payload (`text:...`)

Example: Program NDEF message with two text records.

```
- ident: ICT-T1
  title: Write NFC
  steps:
  - command: define CODE 123
  - command: nfc write NTAG213 text:"Sample Text" text:%CODE%
```

1.2.15 operator - Operator Test

Instruct operator to perform a manual test step.

Usage:

```
operator <message>
```

Example: Instruct operator inspect housing.

```
- ident: ICT-T1
  title: Visual Inspection (manual)
  steps:
  - command: operator "Inspect Housing"
```

1.2.16 pin - Digital pin control

Configure a Digital probe.

Usage:

```
pin <probe> input [pullup]
pin <probe> output [low|high]
```

Argument	Description
probe	Probe (`DDTPxx` or `RDTPxx`)
`input`	Configure as input
`pullup`	Enable pull-up (only for `RDTPxx` pins)
`output`	Configure as output
`low`	Set low
`high`	Set high

Example: Control digital pins

```
suite:
  - ident: ICT-T1
    title: Configure digital inputs
    steps:
    - command: pin DDTP05 input
    - command: pin DDTP03 input
    - command: pin RDTP04 input pullup
  - ident: ICT-T2
    title: Control digital outputs
    steps:
    - command: pin DDTP00 output
    - command: pin DDTP02 output low
    - command: pin RDTP01 output high
```

1.2.17 power - Power Control

Control power applied to the Device Under Test.

Usage:

```
power off
power <rail> [on|off|<level>]
```

Argument	Description
rail	Power rail
`on`	Turn on the specified power rail
`off`	Turn off all or specified power rail
level	Voltage level for `VARV`: 2..12.0

Supported ***rail*** values:

rail	**Description**

rail	**Description**
`3V3`	3.3V power rail
`5V`	5V power rail
`VARV`	Variable power rail
`12V`	12V power rail
`SWD`	SWD (3.3V) power rail
`JTAG`	JTAG (3.3V) power rail
`UART0`	UART0 (3.3V) power rail
`UART1`	UART1 (3.3V) power rail

Example: Apply power

```
suite:
  - ident: ICT-T1
    title: Apply power
    steps:
    - command: power 3V3 on
    - command: power 5V on
    - command: power VARV 10.2
  - ident: ICT-T2
    title: Wait
    steps:
    - command: sleepms 1000
  - ident: ICT-T3
    title: Power off
    steps:
    - command: power off
```

1.2.18 program - Program DUT

Erase and Program DUT MCU on-board flash.

Usage:

```
program <target> [UART0|UART1] [offset1:]<img1>,[offset2:]<img2>,[offset3:]<img3>[,...]
```

Argument	**Description**
target	Target to program
`UART0`, `UART1`	Port for UART targets
offset1	Optional: Offset for 1st image
img1	Firmware Element (Bootloader)
offset2	Optional: Offset for 2nd image
img2	Firmware Element (Application)
offset3	Optional: Offset for 3rd image
img3	Firmware Element (Partitioning)
…	Optional: Additional offsets, images

Supported ***target*** values:

target	**Description**
`AVRATmega168P_ISP`	Atmel AVR ATmega168P(A) (JTAG:ISP)
`AVRATmega168P_XPm`	Atmel AVR ATmega168P(A) (USB, XPmini)
`AVRATmega168PB_ISP`	Atmel AVR ATmega168PB (JTAG:ISP)
`AVRATmega168PB_XPm`	Atmel AVR ATmega168PB (USB, XPmini)
`CC1352`	TI CC1352 RFSoC

target	Description
`DA14580`	Dialog DA14580 RFSoC
`ESP32`	Espressif ESP32 RFSoC (JTAG)
`ESP32_HomeKit`	Espressif ESP32 RFSoC (JTAG; HomeKit)
`ESP32_JTAG`	Espressif ESP32 RFSoC (JTAG)
`ESP32_UART`	Espressif ESP32 RFSoC (esptool)
`nRF52`	Nordic nRF52 RFSoC (SWD)
`nRF52_JLink`	Nordic nRF52 RFSoC (USB, JLink)
`nRF91`	Nordic nRF9160 RFSoC:Cortex-M33 (SWD)
`nRF91_JLink`	Nordic nRF9160 RFSoC:Cortex-M33 (USB, JLink)
`STM32F2`	ST STM32F2xx MCU (SWD)
`STM32F2_STLink`	ST STM32F2xx MCU (USB, ST-Link)
`STM32F4`	ST STM32F4xx MCU (SWD)
`STM32F4_STLink`	ST STM32F4xx MCU (USB, ST-Link)
`STM32L4`	ST STM32L4xx MCU (SWD)
`STM32L4_STLink`	ST STM32L4xx MCU (USB, ST-Link)

1.2.19 scan - Scan Barcode

Scan a barcode using USB-attached barcode scanner.

Usage:

```
scan <format>
```

Argument	Description
format	Format of code to scan

Supported *format* values:

format	Description
`ANY`	Any barcode
`%MAC_ADDRESS%`	48-bit MAC address (`XX:XX:XX:XX:XX:XX`)

1.2.20 serial - Request serial number

Request a serial number through PLTcloud. Under Project Settings in PLTcloud, serial number allocation can be configured to use either monotonic counters, or through a WebHook.

Usage:

```
serial request [<KEY>:<jsonKey>]...
```

Argument	Description
`request`	Request serial number through PLTcloud backend
KEY	Test plan user key to extract from webhook response
jsonKey	Webhook response "extra" map key

When a webhook is selected in PLTcloud, a JSON request will be sent containing:

```
{
    "dut_id": "<DUT IDENTIFIER>",
    "serial_number": "<SERIAL NUMBER>",
    "ble_mac": "<BLE MAC>",
    "mcu_id": "<MCU ID>",
    "MYCUSTOMKEY": "my custom value"
}
```

The API endpoint should return something like:

```
{
    "serial_number": "<SERIAL NUMBER>",
    "extra": {
       "name": "Ben"
    }
}
```

To extract the name field, use the serial request command as below:

```
title: Eventbrite
suite:
- ident: SCAN
  title: Scan
  steps:
  - command: scan ANY
    extractKey: BARCODE
- ident: WEBHOOK
  title: Lookup barcode
  steps:
  - command: serial request NAME:name
  - command: operator %NAME%
- ident: PRINT
  title: Print badge
  steps:
  - command: label keys NAME
```

1.2.21 short - Connect Multiplex channels

Usage:

```
short <muxA> <muxB> set|release
```

Argument	Description
muxA	Multiplex channel (0..3)
muxB	Multiplex channel (0..3)
`set`	Short specified multiplex channels
`release`	Release short between specified multiplex channels

Example: connect multiplex channels

```
suite:
  - ident: ICT-T1
    title: Control shorts
    steps:
    - command: short 0 1 set
    - command: short 1 3 set
    - command: sleepms 1000
  - ident: ICT-T1
    title: 0-2 instead of 0-1
    - command: short 0 1 release
    - command: short 0 2 set
```

1.2.22 sleepms - Delay

Temporarily suspend test suite execution.

Usage:

```
sleepms <duration>
```

Argument	Description
duration	Duration, in milliseconds

1.2.23 uart - Send and Extract UART response

Extract data from UART.

Usage:

```
uartcmd: uart UART0|UART1 [noflush]
  [[expect: <expectText>]
   [extract: <extractText>
    extractKey: <extractKey>...]]
  [send: <sendText>]
```

Argument	Description
`UART0`, `UART1`	UART port
expectText	Text to expect, prior to extraction
extractText	Regular expression to extract
extractKey	Key(s) in which to store extracted text
sendText	Text to send prior to extaction
`noflush`	Don't flush receive buffer before extraction

Example: extract ICCID from cellular modem, storing in the `ICCID` key.

```
- uartcmd: uart UART0
  expect: "+CCID:"
  extract: "CCID: (\\d{20})\r\n"
  extractKey: ICCID
  send: "AT+ICCID\r\n"
```

1.2.24 uartAwait - Await UART response

Wait for a specific UART response.

Usage:

```
uartAwait UART0|UART1 <seconds>
```

Argument	Description
`UART0`, `UART1`	UART port
`seconds`	Time to await response, in seconds

Example:

```
- command: uartExpect UART0 Pressed
- command: operator "Press button"
- command: uartAwait UART0 1
```

1.2.25 uartCfg - Configure UART

Configure a UART port.

Usage:

```
uartCfg UART0|UART1 <speed> [<triplet>]
uartCfg UART0 tp
```

Argument	Description
`UART0`, `UART1`	UART port
speed	Baud rate
triplet	UART configuration triplet: `8N1` or `7E1`
`tp`	Use alternate test points instead of UART. (Only for UART0)

Example:

```
- command: uartCfg UART1 9600 8N1
- command: uartCfg UART0 tp
```

1.2.26 uartExpect - Set expectation for uartAwait

Set a UART response to wait for with the `uartAwait` command.

Usage:

```
uartExpect UART0|UART1 <expect> [noflush]
```

Argument	Description
`UART0`, `UART1`	UART port
expect	String to expect with subsequent `uartAwait` command
`noflush`	Don't flush receive buffer before extraction

Example:

```
- command: uartExpect UART0 Pressed
- command: operator "Press button"
- command: uartAwait UART0 1
```

1.2.27 uartReadTimeout - Test if UART is not transmissing

Test if nothing is received from UART.

Usage:

```
uartReadTimeout UART0|UART1 <seconds> [<sendText>]
```

Argument	Description
`UART0`, `UART1`	UART port
seconds	Number of seconds to wait for incoming data
sendText	Text to send before waiting

Example: Test if modem is shut down.

```
- command: uartReadTimeout UART0 1 "AT"
```